Notice of P	Informacy Cited	Application/Control No. 09/703,845	Reexamination	Applicant(s)/Patent Under Reexamination TOSHIYUKI ET AL.	
Notice of References Cited	ererences Cheu	Examiner	Art Unit		
		Tung X Nguyen	2829	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
-	Α	US-6,069,485	05-2000	Long et al.	324/769
	В	US-6,437,360	08-2002	Cho et al.	257/10
	С	US-6,295,630	09-2001	Tamegaya, Yukio	716/4
	D	US-5,365,477	11-1994	Cooper et al.	365/174
	Е	US-			
	F	US-			
	G	US-			
	н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	O					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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